

*Supplementary Information*

# Characterization of Graphite Oxide and Reduced Graphene Oxide Obtained from Different Graphite Precursors and Oxidized by Different Methods Using Raman Spectroscopy Statistical Analysis

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### The schematic presentation of all variables normalisation

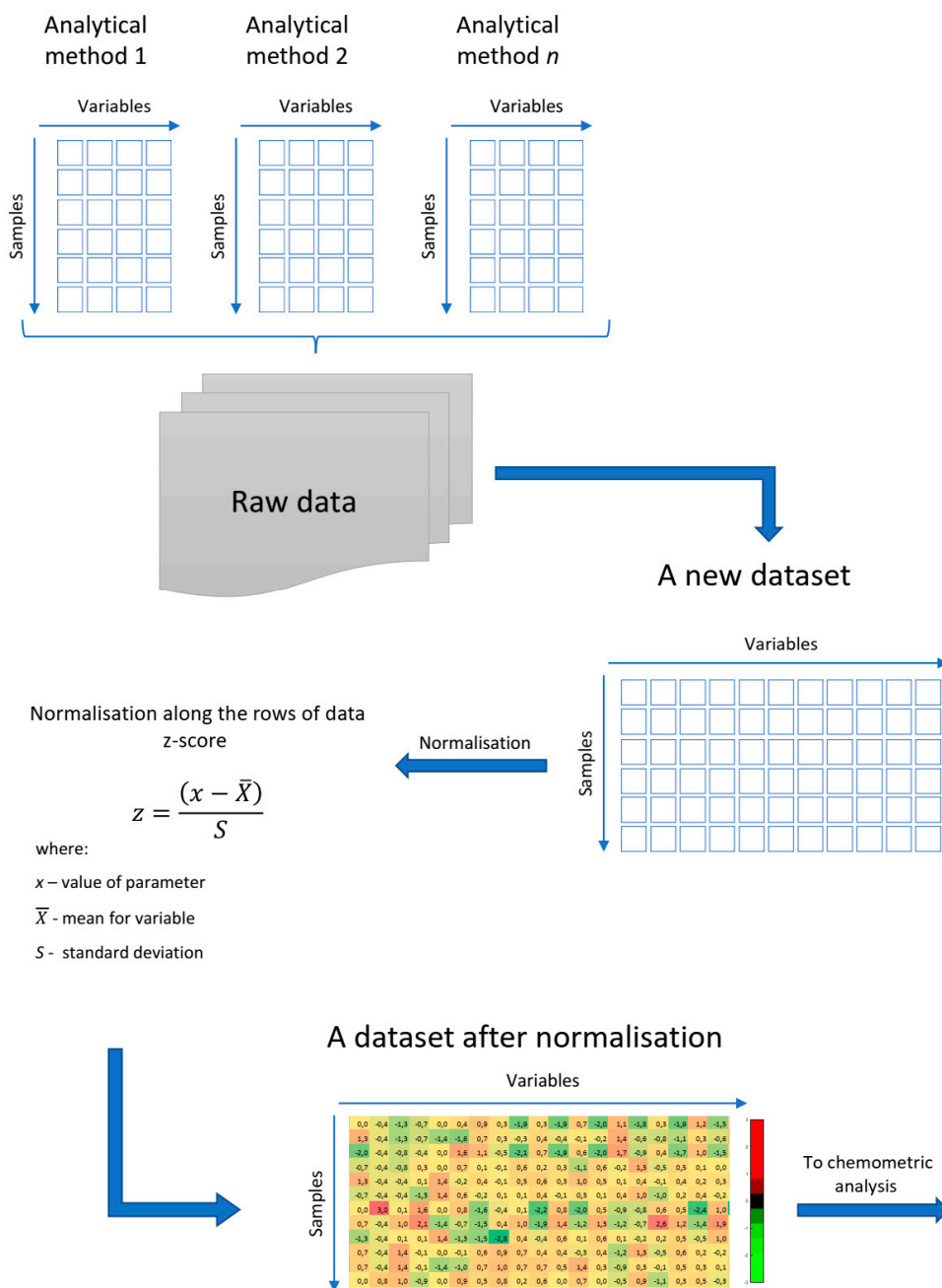


Figure S1. The schematic presentation of normalization of all variables.

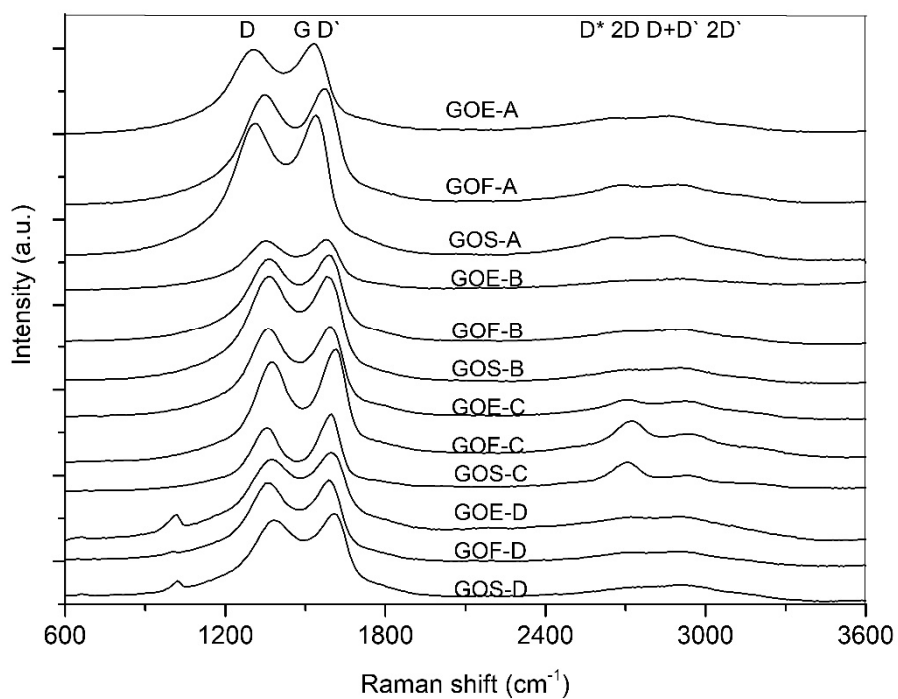


Figure S2. Raman spectra of graphite oxides.

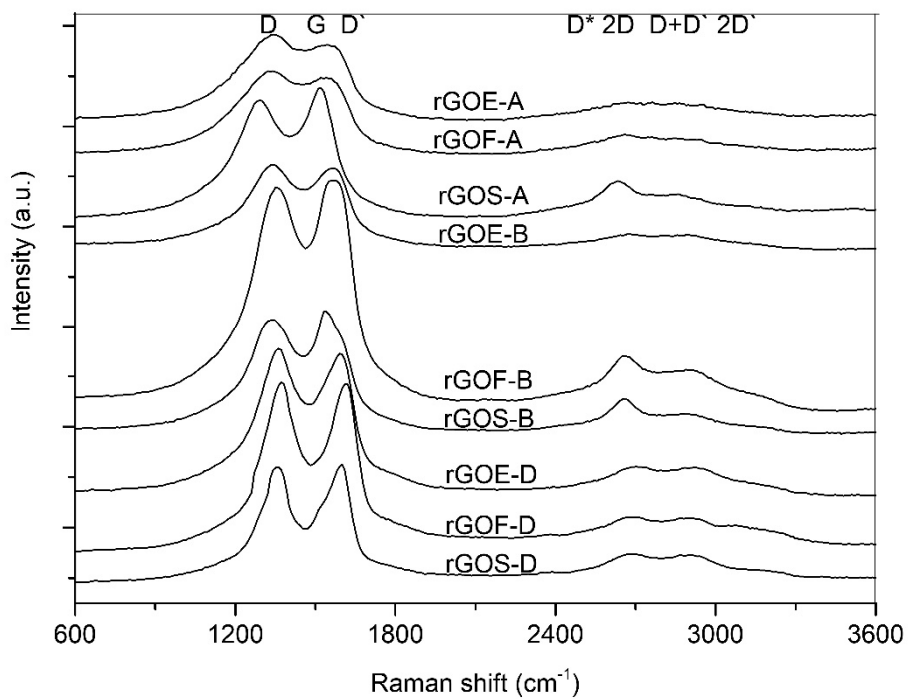


Figure S3. Raman spectra of reduced graphene oxides.

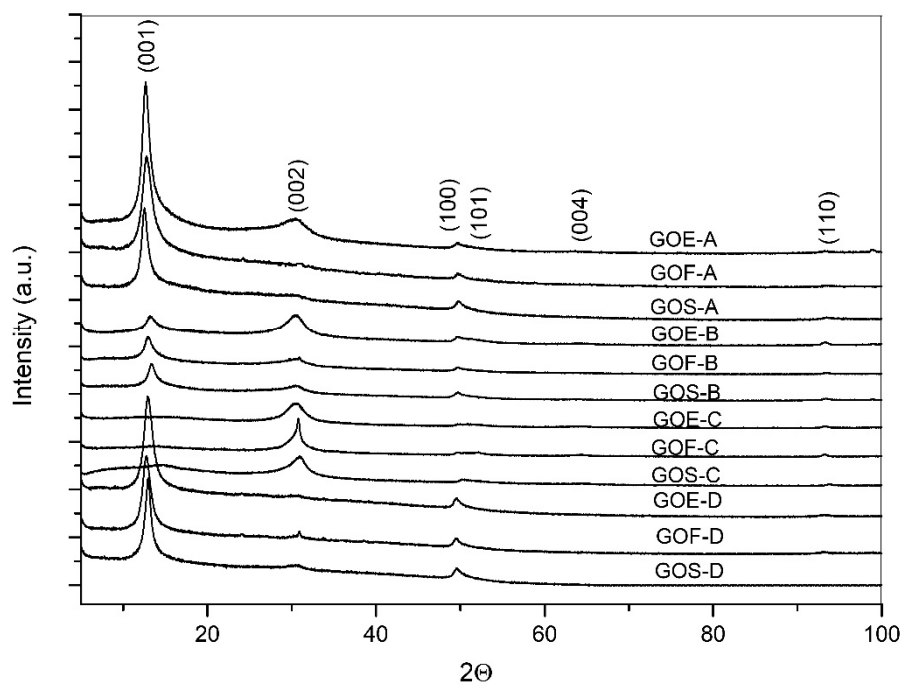


Figure S4. XRD spectra of graphite oxides.

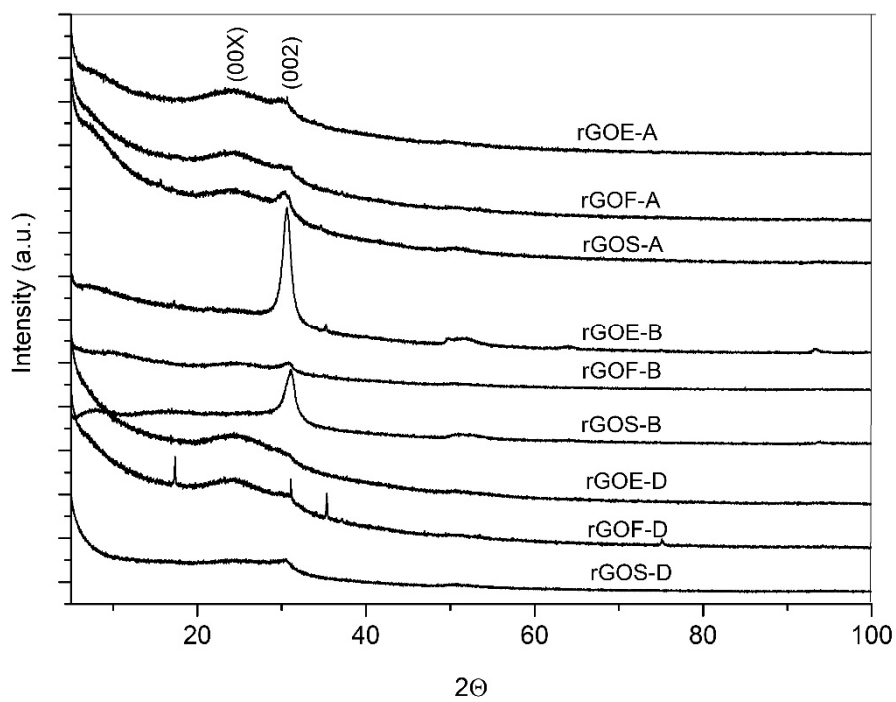


Figure S5. XRD spectra of reduced graphene oxides.